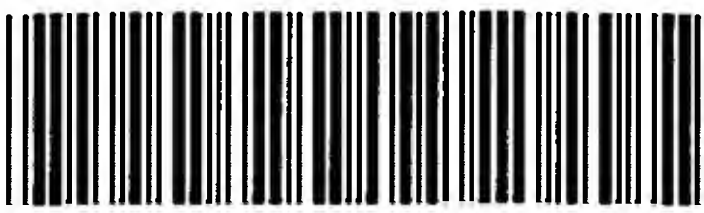


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,135	VELSHER, BENNE	
	Examiner	Art Unit	
	Tina M. Wong	2874	

SEARCHED			
Class	Subclass	Date	Examiner
385	14, 15, 24, 48-52, 129-131	2/9/2006	TMW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Search Updated Same Terms Used	2/9/2006	TMW